High precision half-life measurement of ³⁸Ca

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Progress on the half-life measurement of ³⁸Ca has been previously reported [1,2]. From approximately 19 million β events recorded under various detecting conditions (*i.e.*, different settings for dominant dead time, bias voltage of gas counter, and threshold of discriminator), the measured half-life is 0.4434(4) s, which is consistent with, but much more precise than, the average of all the previous measurements, 0.4400(78) s.

To further improve the precision of the measurement, we performed another ³⁸Ca half-life experiment with the same ¹H(³⁹K, 2*n*) reaction at a primary beam energy of 30*A* MeV. Our experimental arrangement was the same as described before [1, 2]. The overall statistics were substantially improved, but throughout the entire run the level of ³⁵Ar ($t_{1/2} = 1.77$ s) impurity was observed to vary up to ~3% in the reaction products. Since we were depositing ³⁸Ca mid-way through the tape, some ³⁵Ar was simultaneously deposited near the back of the tape. We considered this contribution to the decay of ³⁸Ca and its daughter ³⁸K in extracting the half-life of ³⁸Ca. Although our preliminary result, $t_{1/2}$ (³⁸Ca) = 0.4431(2) s, agrees with our previous measurement, we are planning to conduct the final half-life measurement of ³⁸Ca in the fall of 2009, during which we will reduce the ³⁵Ar contamination by depositing ³⁸Ca near the back of the tape, thus ensuring that the ³⁵Ar passes entirely through.

- H. I. Park *et al.*, *Progress in Research*, Cyclotron Institute, Texas A&M University (2006- 2007), p. I-58.
- [2] H. I. Park *et al.*, *Progress in Research*, Cyclotron Institute, Texas A&M University (2007-2008), p. I-30.